FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. ASA-837-02	SERIAL NO. 10/681,211
LIST OF DOCUMENTS CITED BY APPLICANT *(Use several sheets if necessary)*		APPLICANT F. TOMIYAMA et al	
		FILING DATE October 9, 2003	GROUP 2653

U.S. PATENT DOCUMENTS

* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
	AA	5,270,880	12/1993	Ottesen et al			
	AB	6,081,397	06/2000	Belser, Karl Arnold			
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FOREIGN PATENT DOCUMENTS

		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
	AL						☐	☐
	AM						☐	☐
	AN						☐	☐
	AO						☐	☐
	AP						☐	☐

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, etc.)*

	AR	IEEE TRANSACTIONS ON MAGNETICS, Vol. 29, No. 6, Nov. 1993, "Recording Asymmetries at Large Skew Angles", K. Wiesen et al, pp. 4002-4004.
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EXAMINER	DATE CONSIDERED
Thang V. Tran	10/30/04

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FOREIGN PATENT DOCUMENTS

		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
NL	AL	06-103592	4/15/94	JP (~~with English Abstract~~)			☐	☐
NL	AM	05-094608	4/16/93	JP (~~with English Abstract~~)			☐	☐
	AN						☐	☐
	AO						☐	☐
	AP						☐	☐

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	AS		
	AT		

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